Application/Control No. Applicant(s)/Patent Under Reexamination 10/033,143 WARTH ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1714 Tae H Yoon **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 07-1996 Dalal et al. 430/108.8 US-5,534,379 Α 525/92E 08-2000 Katayama et al. US-6,111,016 В 524/127 US-6,348,527 02-2002 Nodera, Akio С US-D US-Ε US-F US-G US-Н US-1 US-J US-Κ US-L US-М FOREIGN PATENT DOCUMENTS Document Number Date Classification Country Name Country Code-Number-Kind Code MM-YYYY 04-2002 **WIPO** WO 02/32993 Ν О Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W